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APPLICANT  
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## U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	M C
		Country Codes -Number & -Kind Codes (if known)	MM-DD-YYYY			Yes	
		CN 1097526	1/18/1995	UNIV BEIJING		CHINA (w/ English Abstract and Partial English Translation)	
		CN 1257318	6/21/2000	SAMSUNG SDI CO LTD	Corresponds to US 6,291,103 B1	CHINA (w/ English Abstract)	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		Chinese Office Action issued in Chinese Patent Application No. CN 2004800320470 dated on May 30, 2008

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /P.R./